


<b>Search Notes</b>  	<b>Application/Control No.</b>  10543136	<b>Applicant(s)/Patent Under Reexamination</b>  TANIKAWA, AKIO
	<b>Examiner</b>  Caridad M Everhart	<b>Art Unit</b>  2895

SEARCHED			
Class	Subclass	Date	Examiner
257	2, 3, 4, E27.004, E45.002, E43.005, E43.004	12-24-2008	cme
438	102, 104	12-24-2008	cme
365	113, 163, 148	12-24-2008	cme

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(attached)	12-24-2008	cme

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
EAST	attached	12-24-2008	cme

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